

**Search Notes**

Application/Control No.

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Examiner

TUYEN T. NGUYEN

Applicant(s)/Patent under  
Reexamination

POLIVKA ET AL.

Art Unit

2832

**SEARCHED**

Class	Subclass	Date	Examiner
336	65, 83, 183, 192, 200, 220- 223	4/30/2005	TTN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR